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Advanced Optics for Defense Applications: UV through LWIR

Jay N. Vizgaitis Bjørn F. Andresen Peter L. Marasco Jasbinder S. Sanghera Miguel P. Snyder Editors

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The CID Number appears on each page of the manuscript. The complete citation is used on the first page, and an abbreviated version on subsequent pages.

Contents

vii Authors

ix Conference Committee

SESSION 1	MATERIALS
9822 02	Evaluation of chalcogenide glasses for multispectral imaging in the visible, SWIR and LWIR spectral regions [9822-1]
9822 03	Manufacturing of transparent ZnS ceramics by powders sintering [9822-2]
9822 04	Rugged spinel optics for space based imaging systems [9822-3]
9822 05	Engineering novel infrared glass ceramics for advanced optical solutions [9822-4]
9822 07	Designing mid-wave infrared (MWIR) thermo-optic coefficient (dn/dT) in chalcogenide glasses [9822-6]
9822 08	High accuracy refractive index measurement system for germanium and silicon using the channelled spectrum method in the range of 3 to 15 μ m [9822-44]
CECCIONI O	FARRICATION
SESSION 2	FABRICATION
9822 09	Chalcogenide material strengthening through the lens molding process [9822-7]
9822 0A	Applicability of an annealing coefficient for precision glass molding of As ₄₀ Se ₆₀ [9822-8]
9822 OB	Molded, wafer level optics for long wave infra-red applications [9822-9]
9822 0C	Optimum selection of high performance mirror substrates for diamond finishing [9822-40]
9822 OD	Bubble formation in additive manufacturing of glass [9822-37]
SESSION 3	OPTICAL DESIGN AND ANALYSIS I
32331311 0	OF HOLD DESIGN AND ANALYSIS I
9822 0E	Recent advances in joint optical-digital design for optronics applications [9822-10]
9822 OF	Phase mask for infrared lens athermalization: design considerations [9822-11]
9822 0G	Evaluate depth of field limits of fixed focus lens arrangements in thermal infrared [9822-12]
9822 OH	Characterization of the image quality of a wide angle MWIR f-theta objective lens by means of pixel contrast [9822-13]

9822 01	Experimental verification of the minimum number of diffractive zones for effective chromatic correction in the LWIR [9822-14]
SESSION 4	OPTICAL DESIGN AND ANALYSIS II
9822 OJ	Design method for a laser line beam shaper of a general 1D angular power distribution [9822-15]
9822 OK	Electronic eyebox for weapon sights [9822-16]
9822 OL	Time-resolved non-sequential ray-tracing modelling of non-line-of-sight picosecond pulse LIDAR [9822-17]
9822 OM	Novel silicon lenses for long-wave infrared imaging [9822-18]
9822 ON	Expanded IR glass map for multispectral optics designs [9822-19]
9822 00	Computing the PSF with high-resolution reconstruction technique [9822-42]
SESSION 5	GRIN I
3E33ION 5	GRINI
9822 OP	Advanced gradient-index lens design tools to maximize system performance and reduce SWaP [9822-20]
9822 0Q	Materials figure of merit for achromatic gradient index (GRIN) optics [9822-21]
9822 OR	IR-GRIN optics for imaging [9822-22]
9822 OS	Athermal achromat lens enabled by polymer gradient index optics [9822-23]
SESSION 6	GRIN II
9822 OU	Transformation optics relay lens design for imaging from a curved to a flat surface [9822-25]
9822 OV	ALON GRIN optics for visible-MWIR applications [9822-26]
9822 0W	Raman and CT scan mapping of chalcogenide glass diffusion generated gradient index profiles [9822-27]
9822 0X	An analytical study of thermal invariance of polymeric nanolayer gradient index optical components [9822-28]
SESSION 7	COATINGS AND FILTERS
9822 OY	Low-loss crystalline coatings for the near- and mid-infrared [9822-41]

9822 OZ	HfO ₂ /SiO ₂ multilayer based reflective and transmissive optics from the IR to the UV [9822-29]
9822 11	Ultra-narrow bandpass filters for infrared applications with improved angle of incidence performance [9822-31]
9822 12	Acousto-optic tunable filter as a notch filter [9822-32]
9822 13	New counter-countermeasure techniques for laser anti-dazzling spectacles [9822-33]
SESSION 8	OPTICAL DESIGN AND ANALYSIS III
SESSION 8 9822 14	OPTICAL DESIGN AND ANALYSIS III Exploring the imaging properties of thin lenses for cryogenic infrared cameras [9822-35]

Proc. of SPIE Vol. 9822 982201-6

Authors

Numbers in the index correspond to the last two digits of the six-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first four digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

Achtner, Bertram, OH Adam, P., 02 Aiken, S., 05 Alexandrovski, A., 0Y Aspelmeyer, M., 0Y

Bayya, Shyam, 04, 0N, 0R, 0W Beadie, Guy, 0N, 0Q, 0S

Benson, R., 0W Bentley, Julie L., 0V, 15 Berg, R. H., 0W

Berman, Rebecca, 15 Bigou, D., 02

Bigoto, B.J., 02 Bjork, B. J., 07 Bréhault, A., 02 Bristow, Douglas A., 0D Brocker, Donovan E., 0P Bryant, Kyle R., 16 Buff, A., 05

Burcklen, Marie-Anne, 0E

Calvez, L., 02

Campbell, Sawyer D., 0P Chambon, Mathieu, 14 Chan, Susan, 0L Chanda, Sheetal, 11 Chen, FanSheng, 0O Cole, G. D., 0Y Coleman, Garrett J., 09

Coleman, Garrett J., 09
Comstock, Lovell E., 0C
Deegan, J., 01, 0W
Delboulbé, Anne, 0E
Deutsch, C., 0Y
Diaz, Frédéric, 0E
Dong, YucCui, 0O
Donval, Ariela, 13
Druart, Guillaume, 14
Duchêne, M., 02
Duhem, François, 0E
Durand, G., 03
Easum, John A., 0P
Elmalem, Shay, 0F
Faccio, Daniele, 0L
Fein, Howard, 0X

Flynn, Richard A., 0Q, 0S

Follman, D., 0Y Franks, John, 0B Franz, C., 0Y Fredell, Markus, 11

Fennig, Eryn A., 15 Fisher, Tali, 13 Gariepy, Genevieve, 0L Gibson, Daniel, 0N, 0R, 0W Gilbert, Luke J., 0D Gleason, Benn, 07 Goldman, Lee M, 0V Goldstein, Jonathan T., 0D

Goudail, François, 0E Greenhalgh, Catherine, 0K

Gross, N., 0W
Gross, Noam, 13
Grulois, Tatiana, 14
Guerineau, Nicolas, 14
Gupta, Neelam, 12
Hakmeh, N., 03
Hart, Gary A., 0Z
Heckl, O. H., 0Y
Hell, Christian, 08
Henderson, Robert, 0L

Heu, P., 0Y Hunt, Michael, 04 Jha, Santosh, 0V Johnson, Robert, Jr., 11 Kang, M., 05 Kim, Woohong, 04

Kim, Woohong, 04 Kintz, Gregory, 0M Kinzel, Edward C., 0D

Kirk, A., 05 Kotov, Mikhail, 0N, 0R, 0W

Landers, Robert G., 0D Leach, Jonathan, OL Lee, Mane-Si Laure, 0E Lee, Stephen T., OL Lemonnier, Fabrice, 0E Lepkowicz, Richard, 0U Leprêtre, François, OE Lindberg, G. P., 0W Lipman, Ofir, 13 Loiseaux, Brigitte, OE Lucas, Pierre, 09 Luo, Junjie, 0D Ma, H. L., 02 Magli, Serge, 14 Mait, J. N., 0Q Marom, Emanuel, 0F Matallah, Noura, 14 Mayer, T., 05

McCarthy, Peter, 0V McClain, Collin, 0R

Merdrignac-Conanec, O., 03

Miklos, Robert, OR Millet, Philippe, 0E Milojkovic, P., 0Q Moore, Duncan T., 0V, 15 Musgraves, J. David, 05 Nag, Nagendra, 0V Nagar, Jogender, OP Neifeld, Mark, 0U Nelson, J., 09

Nguyen, Vinh, 0N, 0R, 0W Nobes, Ryan, OK

Novak, Jacklyn, 0A Novak, Spencer, 0A Olson, Craig, 15 Oron, Moshe, 13

Oudard, Jean Francois, 0Z

Oved, A., 0J Oved, E., 0J Pain, T., 02 Pantano, C., 05 Partouche, Eran, 13 Peters, Daniel C., 0D Petersen, Kurt, OM

Petropavlovskiy, Dmitry, 15

Plunkett, Simon, 04 Pogrebnyakov, A., 05 Ponting, Michael, 0X Rahmlow, Thomas D., Jr., 11 Ramsey, J. L., 01

Richardson, Kathleen, 05, 07

Rivero-Baleine, C., 05 Rollin, J., 02 Roy, Brian P., OZ Salvaggio, P. S., OW

Sanghera, Jasbinder, 04, 0N, 0R, 0W Sastri, Suri, OV

Sauer, Hervé, 0E Schmidt, Greg R., 0V Schuster, Norbert, 0G Scordato, M., 09 Sisken, Laura, 05, 07 Smith, Charmayne, 05, 07 Smith, M., OI

Sonderhouse, L., 0Y Sroka, Adam, OL Stephanou, Philip, 0M Steven, Samuel J., 15 Stover, Erik, 0A Straube, Hilmar, 08 Su, Xiaofeng, 00 Sutherland, James S., OC

Swisher, A., 05

Szapiel, Stan, OK Turpin, Jeremiah P., 0P Urbas, Augustine M., 0D Verdet, Sebastien, 14

Villalobos, Guillermo, 04

Wachtel, P., 05

Wagner, Kevin, OK

Symmons, Alan, 0A

Walsh, K. F., Ol

Wamboldt, Leonard, OC, OZ

Wang, Jue, 0Z Warburton, Ryan, OL Weinstein, B. A., OW Werner, Douglas H., 05, 0P Wetherill, Julia, 0U Woodard, Kenneth S., OC

Xue, Yulong, 00 Yang, Xue, 00 Ye, J., 0Y

Yee, Anthony J., 15 Zahreddine, Ramzi, OU Zhang, W., 0Y Zhang, X.-H., 02, 03 Zhao, Yang, 15

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